

<b>Notice of References Cited</b>	Application/Control No. 10/055,811	Applicant(s)/Patent Under Reexamination VEDRUCCIO, CLARBRUNO	
	Examiner Arlen Soderquist	Art Unit 1797	Page 1 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,240,445	12-1980	Iskander et al.	607/156
*	B	US-5,262,957	11-1993	Hearn, Brian F.	702/76
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Smialowicz, R. J. et al, Bioelectromagnetics 1982, 3, 467-470.
	V	Juroshek, J. R. et al, IMTC/84, IEEE Instrumentation and Measurement Technology Conference Proceedings, 1984, 78-79, Publisher: IEEE, New York, NY, USA.
	W	Rappaport, C. M. et al, Journal of Microwave Power and Electromagnetic Energy 1987, 22, 71-78.
	X	Meltz, M. L. et al, Radiation Research 1987, 110, 255-266.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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	A	US-			
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	J	US-			
	K	US-			
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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Regan, A. H. et al, Conference Record IEEE Particle Acceleration Conference, 14th 1991, 5, 2946-2948.
	V	Adair, E. R. et al, Bioelectromagnetics 1992, 13, 497-512.
	W	Belozerova, T. S. et al, Soviet Technical Physics Letters 1992, 18, 404-405.
	X	Brill, G. E. et al, SPIE 1996, 2678, 519-529.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	A	US-			
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	C	US-			
	D	US-			
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	N					
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	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Adair, E. R. et al, Bioelectromagnetics 1998, 19, 232-245.
	V	
	W	
	X	

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